

# HAC RF TEST REPORT

# No. I17N00032-HAC RF

For

# Yulong Computer Telecommunication Scientific (Shenzhen) Co., Ltd Smart phone

Model Name: Coolpad3632A

With

**Hardware Version: P2** 

Software Version: 7.0.013.00.P0.161201.3632A.tmo

**FCC ID: R38YL3632A** 

**Results Summary: M Category = M4** 

Issued Date: 2017-02-19

#### Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

#### **Test Laboratory:**

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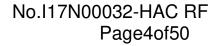
# **REPORT HISTORY**

Report Number Revision		Issue Date	Description	
I17N00032-HAC RF Rev.0		2017-02-19	Initial creation of test report	



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# 1 Test Laboratory

# 1.1 Testing Location

Company Name:	CTTL(Shenzhen)			
Address:	Multimedia Building, TCL International E City, Zhongshan Road,			
	Nanshan District, Shenzhen, P. R. China			

#### 1.2 Testing Environment

Temperature:	18°C~25 °C,
Relative humidity:	30%~ 70%
Ground system resistance:	< 4 Ω
Ambient noise & Reflection:	< 0.012 W/kg

## 1.3 Project Data

Project Leader:	Zhang Yunzhuan			
Test Engineer:	Wang Fen			
Testing Start Date:	February 10, 2017			
Testing End Date:	February 10, 2017			

## 1.4 Signature

Wang Fen

(Prepared this test report)

Zhang Yunzhuan

(Reviewed this test report)

Cao Junfei

Director of the laboratory (Approved this test report)



# **2 Client Information**

# 2.1 Applicant Information

Company Name:	Yulong Computer Telecommunication Scientific (Shenzhen) Co., Ltd					
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	Nanshan District, Shenzhen, P.R.C.					
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Telephone:	0755-83301199-83335					
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#### 2.2 Manufacturer Information

Company Name:	Yulong Computer Telecommunication Scientific (Shenzhen) Co., Ltd						
Address /Post:	Coolpad Information Harbor, High-tech Industrial Park (North),						
	Nanshan District, Shenzhen, P.R.C.						
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Email:	wangping1@yulong.com						
Telephone:	0755-83301199-83335						
Fax:	/						



# 3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

#### 3.1 About EUT

Description:	Smart phone			
Mode Name:	Coolpad 3632A			
Operating mode(s):	GSM 850/1900/900/1800, WCDMA 850/1700/1900,			
	LTE_FDD Band 2/4/5/12, BT, Wi-Fi 2.4G			

#### 3.2 Internal Identification of EUT used during the test

EUT ID* IMEI		HW Version SW Version	
EUT1	862006030007045	P2	7.0.013.00.P0.161201.3632A.tmo
EUT2	862006030009256	P2	7.0.013.00.P0.161201.3632A.tmo

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.

Note: It is performed to test HAC with the EUT1 and conducted power with the EUT2.

#### 3.3 Internal Identification of AE used during the test

AE ID*	Description	Model	SN	Manufacturer	
AE1	Battery	CPLD-417	CPLD41716424000001	Zhuhai COSLIGHT Battery CO., Ltd.	
AE2	Battery	CPLD-417	CPLD41716424000001	Tianjin Lishen Battery Joint-Stock Co.,Ltd.	

<sup>\*</sup>AE ID: is used to identify the test sample in the lab internally.

#### 3.4 Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Туре	C63.19/tested	Simultaneous Transmissions	ОТТ	Power Reduction
GSM	850	VO	Yes		NA	NA
GSIVI	1900	VO	162	BT,WLAN		
GPRS/EDGE	850	DT	NA	DI,VVLAIN		No
GPN3/EDGE	1900	וט	INA			
	850			BT,WLAN	NA	
WCDMA (UMTS)	1700	VO	Yes			NA
	1900					
	HSPA	DT	NA			
	1900		NA	BT,WLAN	NA	NA
LTE	1800	VD				
LTE	700	VD		DI,VVLAIN		INA
	850					
ВТ	2450	DT	NA	GSM, WCDMA,LTE	NA	NA
WLAN	2450	DT	NA	GSM, WCDMA,LTE	NA	NA

VO: Voice CMRS/PSTN Service OnlyV/D: Voice CMRS/PSTN and Data Service



DT: Digital Transport

\* HAC Rating was not based on concurrent voice and data modes; Non-current mode was found to represent worst case rating for both M and T rating

#### 4 CONDUCTED OUTPUT POWER MEASUREMENT

#### 4.1 Summary

During the process of testing, the EUT was controlled via Agilent Digital Radio Communication tester (E5515C) to ensure the maximum power transmission and proper modulation. This result contains conducted output power for the EUT. In all cases, the measured output power should be greater and within 5% than EMI measurement.

#### **4.2 Conducted Power**

CCM		Conducted Power (dBm)				
GSM 850MHz	Channel 251(848.8MHz)	Channel 190(836.6MHz)	Channel 128(824.2MHz)			
OSUMITIZ	32.54	32.93	32.80			
GSM		Conducted Power(dBm)				
1900MHz	Channel 810(1909.8MHz)	Channel 661(1880MHz)	Channel 512(1850.2MHz)			
1900WITZ	29.62	30.08	30.48			
WCDMA	Conducted Power (dBm)					
850MHz	Channel 4233(846.6MHz) Channel 4182(836.4MHz)		Channel 4132(826.4MHz)			
OSUMITIZ	23.84	23.86	23.93			
WCDMA	Conducted Power (dBm)					
1700MHz	Channel 1513(1752.6MHz)	Channel 1412(1732.4MHz)	Channel 1312(1712.4MHz)			
1700WITZ	24.86	24.86 24.77				
WCDMA		Conducted Power (dBm)				
1900MHz	Channel 9538(1907.6MHz)	Channel 9400(1880MHz)	Channel 9262(1852.4MHz)			
1 300 WIT IZ	23.69	23.83	23.78			

#### 5. Reference Documents

The following document listed in this section is referred for testing.

Reference	Title	Version
ANSI C63.19-2011	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids	2011 Edition
KDB 285076 D01	Equipment Authorization Guidance for Hearing Aid Compatibility	v04



#### **6 OPERATIONAL CONDITIONS DURING TEST**

#### 6.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid& Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core2 1.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

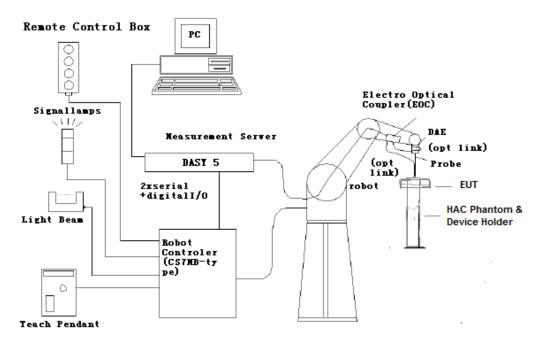


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



#### 6.2 Probe Specification

#### E-Field Probe Description

Construction One dipole parallel, two dipoles normal to probe axis

Built-in shielding against static charges

PEEK enclosure material

Calibration In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%,

k=2)

Frequency 40 MHz to > 6 GHz (can be extended to < 20 MHz)

Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity  $\pm 0.2 \text{ dB}$  in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

DynamicRange 2 V/m to > 1000 V/m; Linearity:  $\pm$  0.2 dB

Dimensions Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm

Application General near-field measurements up to 6 GHz

Field component measurements

Fast automatic scanning in phantoms



[ER3DV6]



#### 6.3 Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions:  $370 \times 370 \times 370 \text{ mm}$ ).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field <±0.5 dB.



Fig. 2 HAC Phantom & Device Holder

#### 6.4 Robotic System Specifications

#### **Specifications**

Positioner: StäubliUnimation Corp. Robot Model: RX160XL

Repeatability: ±0.02 mm

No. of Axis: 6

#### Data Acquisition Electronic (DAE) System

**Cell Controller** 

Processor: Intel Core2 Clock Speed: 1.86 GHz

**Operating System: Windows XP** 

**Data Converter** 

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock



#### **7 EUT ARRANGEMENT**

#### 7.1 WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear
- The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

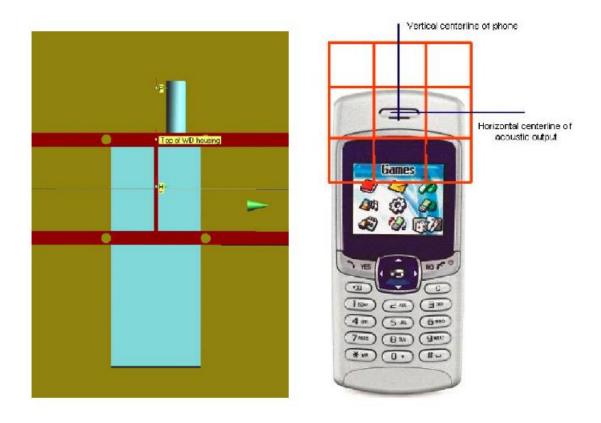


Fig. 3 WD reference and plane for RF emission measurements



#### **8 SYSTEM VALIDATION**

#### 8.1 Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical output. Position the E-field probes so that:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) are 15 mm from the closest surface of the dipole elements.

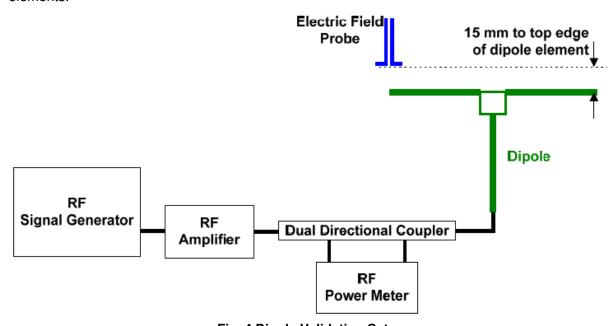


Fig. 4 Dipole Validation Setup

#### 8.2 Validation Result

	E-Field Scan								
Mode	Frequency	Input Power	Measured <sup>1</sup>	Target <sup>2</sup>	Deviation <sup>3</sup>	Limit <sup>4</sup>			
wode	(MHz)	(mW)	Value(dBV/m)	Value(dBV/m)	(%)	(%)			
CW	835	100	41.22	40.59	1.6	±25			
CW	1880	100	39.87	39.14	1.9	±25			

#### Notes:

- 1. Please refer to the attachment for detailed measurement data and plot.
- 2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
- 3. Deviation (%) = 100 \* (Measured value minus Target value) divided by Target value.
- 4. ANSI C63.19 requires values within  $\pm$  25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.



#### 9 Evaluation of MIF

#### 9.1 Introduction

The MIF (Modulation Interference Factor) is used to classify E-field emission to determine Hearing Aid Compatibility (HAC). It scales the power-averaged signal to the RF audio interference level and is characteristic to a modulation scheme. The HAC standard preferred "indirect" measurement method is based on average field measurement with separate scaling by the MIF. With an Audio Interference Analyzer (AIA) designed by SPEAG specifically for the MIF measurement, these values have been verified by practical measurements on an RF signal modulated with each of the waveforms. The resulting deviations from the simulated values are within the requirements of the HAC standard.

The AIA (Audio Interference Analyzer) is an USB powered electronic sensor to evaluate signals in the frequency range 698 MHz - 6 GHz. It contains RMS detector and audio frequency circuits for sampling of the RF envelope.

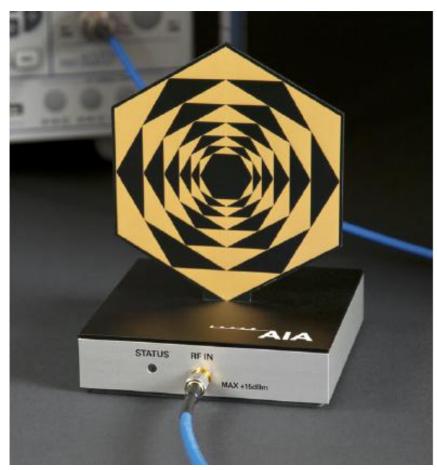


Fig. 5 AIA Front View



#### 9.2MIF measurement with the AIA

The MIF is measured with the AIA as follows:

- 1. Connect the AIA via USB to the DASY5 PC and verify the configuration settings.
- 2. Couple the RF signal to be evaluated to an AIA via cable or antenna.
- 3. Generate a MIF measurement job for the unknown signal and select the measurement port and timing settings.
- 4. Document the results via the post processor in a report.

#### 9.3Test equipment for the MIF measurement

No.	Name	Туре	Serial Number	Manufacturer
01	Signal Generator	E8257D	MY47461211	Agilent
02	AIA	SE UMS 170 CB	1050	SPEAG
03	BTS	CMU200	114545	Rohde&Shwarz

#### 9.4 Test signal validation

The signal generator (E4438C) is used to generate a 1GHz signal with different modulation in the below table based on the ANSI C63.19-2011. The measured MIF with AIA are compared with the target values given in ANSI C63.19-2011 table D.3, D.4 and D.5

Pulse modulation	Target MIF	Measured MIF	Deviation
0.5ms pulse, 1000Hz repetition rate	-0.9 dB	-0.9 dB	0 dB
1ms pulse, 100Hz repetition rate	+3.9 dB	+3.7 dB	0.2 dB
0.1ms pulse, 100Hz repetition rate	+10.1 dB	+10.0 dB	0.1 dB
10ms pulse, 10Hz repetition rate	+1.6 dB	+1.8 dB	0.2 dB
Sine-wave modulation	Target MIF	Measured MIF	Deviation
1 kHz, 80% AM	-1.2 dB	-1.3 dB	0.1 dB
1 kHz, 10% AM	-9.1 dB	-9.0 dB	0.1 dB
1 kHz, 1% AM	-19.1 dB	-18.9 dB	0.2 dB
100 Hz, 10% AM	-16.1 dB	-16.0 dB	0.1 dB
10 kHz, 10% AM	-21.5 dB	-21.7 dB	0.2 dB
Transmission protocol	Target MIF	Measured MIF	Deviation
GSM; full-rate version 2; speech codec/handset low	+3.5 dB	+3.46 dB	0.04 dB
WCDMA; speech; speech codec low; AMR 12.2 kb/s	-20.0 dB	-19.7 dB	0.3 dB



#### 9.5 DUT MIF results

Typical MIF levels in ANSI C63.19-2011					
Transmission protocol Modulation interference factor					
GSM; full-rate version 2; speech codec/handset low	+3.5 dB				
WCDMA; speech; speech codec low; AMR 12.2 kb/s	-20.0 dB				

	Measured MIF levels							
Band	Channel	Modulation interference factor						
	251	+3.46dB						
GSM 850	190	+3.45 dB						
	128	+3.43 dB						
	810	+3.42 dB						
GSM 1900	661	+3.43 dB						
	512	+3.40dB						
	4233	-19.73 dB						
WCDMA 850	4182	-19.73 dB						
	4132	-19.76 dB						
	1513	-19.65 dB						
WCDMA 1700	1412	-19.62 dB						
	1312	-19.58 dB						
	9538	-19.66 dB						
WCDMA 1900	9400	-19.64 dB						
	9262	-19.59 dB						



#### 10 Evaluation for low-power exemption

#### 10.1 Product testing threshold

There are two methods for exempting an RF air interface technology from testing. The first method requires evaluation of the MIF for the worst-case operating mode. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is  $\leq$ 17 dBm for any of its operating modes. The second method does not require determination of the MIF. The RF emissions testing exemption shall be applied to an RF air interface technology in a device whose peak antenna input power, averaged over intervals  $\leq$ 50  $\mu$ s20, is  $\leq$ 23 dBm. An RF air interface technology that is exempted from testing by either method shall be rated as M4. The first method is used to be exempt from testing for the RF air interface technology in this report.

#### 10.2 Conducted power

Band	Average power (dBm)	MIF (dB)	Sum (dBm)
GSM 850	32.93	3.45	36.38
GSM 1900	30.48	3.40	33.88
WCDMA 850	23.93	-19.76	3.24
WCDMA 1700	24.88	-19.58	5.30
WCDMA 1900	23.83	-19.64	4.19

#### 10.3 Conclusion

According to the above table, the sums of average power and MIF for UMTS are less than 17dBm. So it is only measured for GSM bands. The UMTS bands are exempt from testing and rated as M4.



#### 11 RF TEST PROCEDUERES

#### The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplify this positioning.
- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point orthe acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading ateach measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Evaluate the MIF and add to the maximum steady-state rms field-strength reading to obtain the RF audio interference level..
- Compare this RF audio interference level with the categories and record the resulting WD category rating.



# 12Measurement Results (E-Field)

Fred	luency	Measured Value	Power Drift	Category
MHz	Channel	(dBV/m)	(dB)	
		GSM 8	50	•
848.8	251	38.61	-0.06	M4(see Fig B.1)
836.6	190	38.83	0.07	M4(see Fig B.2)
824.2	128	38.72	0.04	M4 (see Fig B.3)
		GSM 19	00	•
1909.8	810	25.79	-0.09	M4(see Fig B.4)
1880	661	27.08	0.02	M4(see Fig B.5)
1850.2	512	27.70	0.05	M4 (see Fig B.6)

# 13ANSI C 63.19-2011 LIMITS

#### WD RF audio interference level categories in logarithmic units

Emission categories	< 960 MHz				
	E-field emissions				
Category M1	50 to 55	dB (V/m)			
Category M2	45 to 50	dB (V/m)			
Category M3	40 to 45	dB (V/m)			
Category M4	< 40	dB (V/m)			
Emission categories	>960	MHz			
	E-field er	missions			
Category M1	40 to 45	dB (V/m)			
Category M2	35 to 40	dB (V/m)			
Category M3	30 to 35	dB (V/m)			
Category M4	< 30	dB (V/m)			



# **14 MEASUREMENT UNCERTAINTY**

No.	Error source	Туре	Uncert ainty Value (%)	Prob. Dist.	k	c <sub>i</sub> E	Standard Uncertainty (%) u'_i(%) E	Degree of freedom V <sub>eff</sub> or v <sub>i</sub>	source
1	System repeatability	Α	0.24	N	1	1	0.24	9	Measurement
Meas	surement System			I.	I		•		
2	Probe Calibration	В	10.1	N	1	1	10.1	∞	Manufacturer
3	Axial Isotropy	В	0.5	R	$\sqrt{3}$	1	0.5	∞	Cal report
4	Sensor Displacement	В	16.5	R	$\sqrt{3}$	1	9.5	∞	Manufacturer
5	Boundary Effects	В	2.4	R	$\sqrt{3}$	1	1.4	∞	Manufacturer
6	Linearity	В	0.6	R	$\sqrt{3}$	1	0.35	∞	Cal report
7	Scaling to Peak Envolope Power	В	2.0	R	$\sqrt{3}$	1	1.2	∞	Standard
8	System Detection Limit	В	1.0	R	$\sqrt{3}$	1	0.6	8	Manufacturer
9	Readout Electronics	В	0.3	N	1	1	0.3	∞	Manufacturer
10	Response Time	В	0.8	R	$\sqrt{3}$	1	0.5	∞	Manufacturer
11	Integration Time	В	2.6	R	$\sqrt{3}$	1	1.5	∞	Manufacturer
12	RF Ambient Conditions	В	3.0	R	$\sqrt{3}$	1	1.7	∞	Measurement
13	RF Reflections	В	12.0	R	$\sqrt{3}$	1	6.9	∞	Measurement
14	Probe Positioner	Α	1.2	R	$\sqrt{3}$	1	0.7	∞	Manufacturer
15	Probe Positioning	Α	4.7	R	$\sqrt{3}$	1	2.7	∞	Manufacturer
16	Extra. And Interpolation	В	1.0	R	$\sqrt{3}$	1	0.6	∞	Manufacturer
Test	Sample Related								
17	Device Positioning Vertical	В	4.7	R	$\sqrt{3}$	1	2.7	∞	Manufacturer
18	Device Positioning Lateral	В	1.0	R	$\sqrt{3}$	1	0.6	∞	Manufacturer
19	Device Holder and Phantom	В	2.4	R	$\sqrt{3}$	1	1.4	∞	Manufacturer
20	Power Drift	В	5.0	R	$\sqrt{3}$	1	2.9	∞	Measurement
Phar	ntom and Setup related								
21	Phantom Thickness	В	2.4	R	$\sqrt{3}$	1	1.4	∞	Manufacturer
PMF	related								
22	Monitor amplitude	В	3.5	R	$\sqrt{3}$	1	2.02	∞	Manufacturer
23	Setup repeatability	Α	2.3	N	1	1	2.3	9	Manufacturer
24	Sensor amplitude	В	12	R	$\sqrt{3}$	1	6.93	∞	Manufacturer
	Combined standard uncertaint	y(%)					18.3		
	Expanded uncertainty (confidence interval of 95 %)	$u_e$	$=2u_c$	N	k=	=2	36.6		



#### **15 MAIN TEST INSTRUMENTS**

**Table 1: List of Main Instruments** 

No.	Name	Туре	Serial Number	Calibration Date	Valid Period
01	Signal Generator	E8257D	MY47461211 2016-06-15		One year
02	Power meter	NRP	102603	2017-01-06	One year
03	Power sensor	NRP-Z51	102211	2017-01-00	One year
04	Amplifier	VTL5400	0404	/	
05	E-Field Probe	ER3DV6	2424	2015-01-23	Three year
06	HAC Dipole	CD835V3	1165	2015-07-20	Three year
07	HAC Dipole	CD1880V3	1149	2015-07-20	Three year
08	BTS	CMU200	114545	2016-05-19	One year
09	DAE	SPEAG DAE4	786	2016-12-08	One year
10	AIA	SE UMS 170 CB	1050	/	

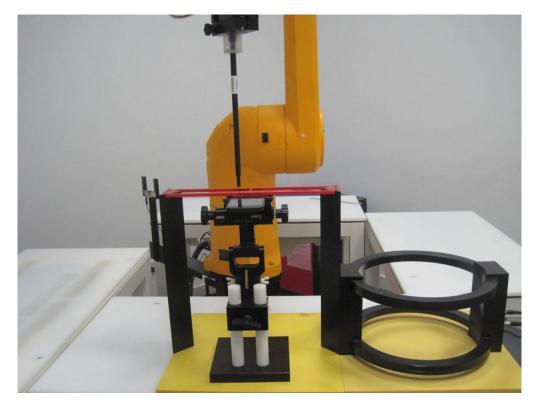
#### **16 CONCLUSION**

The HAC measurement indicates that the EUT complies with the HAC limits of the ANSI C63.19-2011. The total M-rating is **M4.** 

\*\*\*END OF REPORT BODY\*\*\*



# **ANNEX A TEST LAYOUT**



Picture A1: HAC RF System Layout



#### ANNEX B TEST PLOTS

#### HAC RF E-Field GSM 850 High

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C

Communication System: GSM Frequency: 848.8 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

#### E Scan - ER3DV6- 2011:15 mm from Probe Center to the Device H/Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

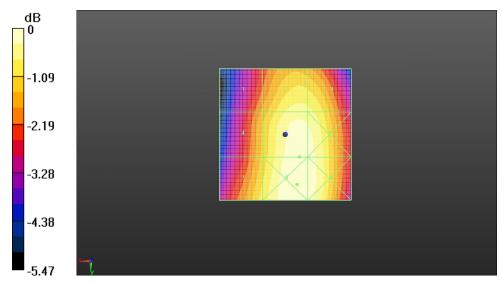
Reference Value = 71.76 V/m; Power Drift = -0.06 dB

Applied MIF = 3.46 dB

RF audio interference level = 38.61 dBV/m

MIF scaled E-field

Grid 1 <b>M4</b>	Grid 2 <b>M4</b>	Grid 3 <b>M4</b>	
37.04 dBV/m	38.19 dBV/m	38.13 dBV/m	
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4	
37.4 dBV/m	38.61 dBV/m	38.55 dBV/m	
Grid 7 <b>M4</b>	Grid 8 M4	Grid 9 M4	
37.81 dBV/m	38.72 dBV/m	38.62 dBV/m	



0 dB = 86.30 V/m = 38.72 dBV/m

Fig B.1 HAC RF E-Field GSM 850 High



#### HAC RF E-Field GSM 850 Middle

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C

Communication System: GSM Frequency: 836.6 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

#### E Scan -ER3DV6 - 2011:15 mm from Probe Center to the Device M/Hearing Aid Compatibility

**Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

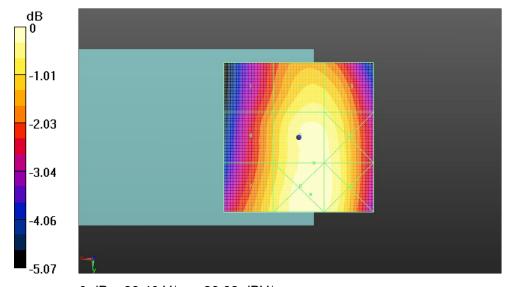
Reference Value = 71.37 V/m; Power Drift = 0.07 dB

Applied MIF = 3.45 dB

RF audio interference level = 38.83 dBV/m

MIF scaled E-field

Grid 1 <b>M4</b>	Grid 2 <b>M4</b>	Grid 3 M4
37.34 dBV/m	38.43 dBV/m	38.35 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4
37.69 dBV/m	38.83 dBV/m	38.75 dBV/m
Grid 7 <b>M4</b>	Grid 8 M4	Grid 9 M4
38.1 dBV/m	38.93 dBV/m	38.81 dBV/m



0 dB = 88.40 V/m = 38.93 dBV/m

Fig B.2 HAC RF E-Field GSM 850 Middle



#### HAC RF E-Field GSM 850 Low

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 S/m,  $\varepsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Ambient Temperature:22.0°C Liquid Temperature:21.5°C

Communication System: GSM Frequency: 824.2 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1);

#### E Scan -ER3DV6 -2011: 15 mm from Probe Center to the Device L/Hearing Aid Compatibility

**Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

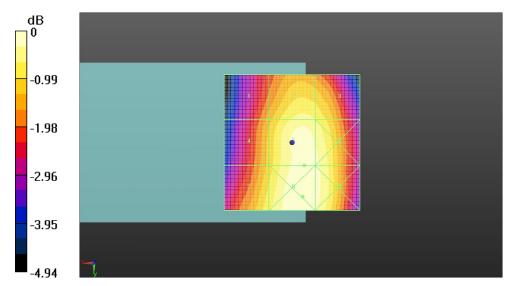
Reference Value = 71.24 V/m; Power Drift = 0.04 dB

Applied MIF = 3.43 dB

RF audio interference level = 38.72 dBV/m

MIF scaled E-field

Grid 1 <b>M4</b>	Grid 2 <b>M4</b>	Grid 3 <b>M4</b>
37.42 dBV/m	38.35 dBV/m	38.21 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4
37.71 dBV/m	38.72 dBV/m	38.65 dBV/m
Grid 7 <b>M4</b>	Grid 8 M4	Grid 9 M4
38.12 dBV/m	38.86 dBV/m	38.69 dBV/m



0 dB = 87.72 V/m = 38.86 dBV/m

Fig B.3 HAC RF E-Field GSM 850 Low



#### HAC RF E-Field GSM 1900 High

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C

Communication System: GSM Frequency: 1910 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1);

#### E Scan -ER3DV6 - 2011:15 mm from Probe Center to the Device H/Hearing Aid Compatibility

**Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

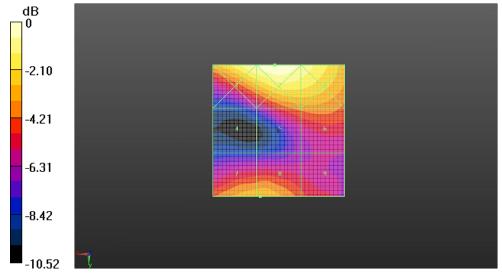
Reference Value = 8.061 V/m; Power Drift = -0.09 dB

Applied MIF = 3.42 dB

RF audio interference level = 25.79 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
28.26 dBV/m	28.65 dBV/m	27.87 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4
21.79 dBV/m	24.74 dBV/m	24.89 dBV/m
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
25.77 dBV/m	25.79 dBV/m	24.07 dBV/m



0 dB = 27.08 V/m = 28.65 dBV/m

Fig B.4 HAC RF E-Field GSM 1900 High



#### HAC RF E-Field GSM 1900 Middle

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C

Communication System: GSM Frequency: 1880 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1);

#### E Scan -ER3DV6 - 2011:15 mm from Probe Center to the Device M/Hearing Aid Compatibility

**Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

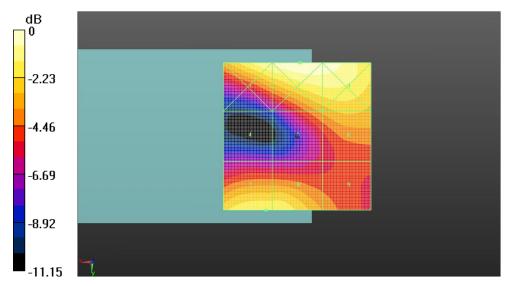
Reference Value = 7.388 V/m; Power Drift = 0.02 dB

Applied MIF = 3.43 dB

RF audio interference level = 27.08 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4	
28 dBV/m	28.57 dBV/m	28.34 dBV/m	
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4	
21.79 dBV/m	25.1 dBV/m	25.79 dBV/m	
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>	
27.08 dBV/m	27.08 dBV/m 24.83 dBV		



0 dB = 26.84 V/m = 28.58 dBV/m

Fig B.5 HAC RF E-Field GSM 1900 Middle



#### HAC RF E-Field GSM 1900 Low

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C

Communication System: GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

#### E Scan -ER3DV6 - 2011:15 mm from Probe Center to the Device L/Hearing Aid Compatibility

**Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

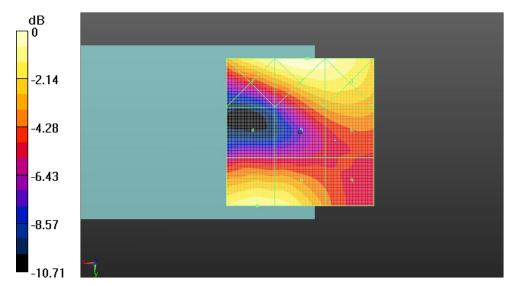
Reference Value = 7.354 V/m; Power Drift = 0.05 dB

Applied MIF = 3.40 dB

RF audio interference level = 27.70 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
28 dBV/m	28.44 dBV/m	28.12 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4
22.65 dBV/m	24.98 dBV/m	25.44 dBV/m
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
27.7 dBV/m	27.44 dBV/m	24.62 dBV/m



0 dB = 26.42 V/m = 28.44 dBV/m

Fig B.6 HAC RF E-Field GSM 1900 Low



#### ANNEX C SYSTEM VALIDATION RESULT

#### **E SCAN of Dipole 835 MHz**

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 mho/m,  $\varepsilon$ r = 1;  $\rho$  = 1000 kg/m3 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD835 Dipole =

15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000

mm

Device Reference Point: 0, 0, -6.3 mm

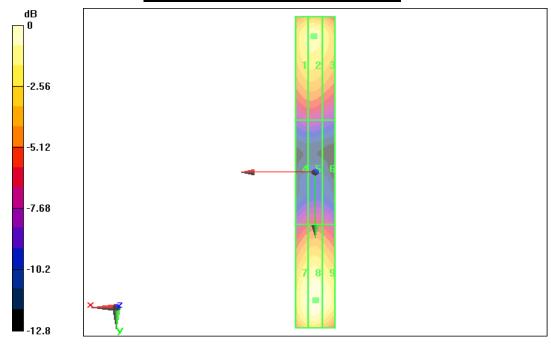
Reference Value = 122.4 V/m; Power Drift = -0.05 dB

Applied MIF = 0.00 dB

RF audio interference level = 41.22dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 <b>M3</b>	Grid 3 M3
40.99dBV/m	41.22dBV/m	41.12dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
36.18dBV/m	36.51dBV/m	36.46dBV/m
Grid 7 M3	Grid 8 M3	Grid 9 <b>M3</b>
40.67dBV/m	40.84dBV/m	40.73dBV/m



0 dB = 41.22 dBV/m



#### **E SCAN of Dipole 1880 MHz**

Date/Time: 2017-2-10 Electronics: DAE4 Sn786

Medium: Air

Medium parameters used:  $\sigma$  = 0 mho/m,  $\varepsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000

mm

Device Reference Point: 0, 0, -6.3 mm

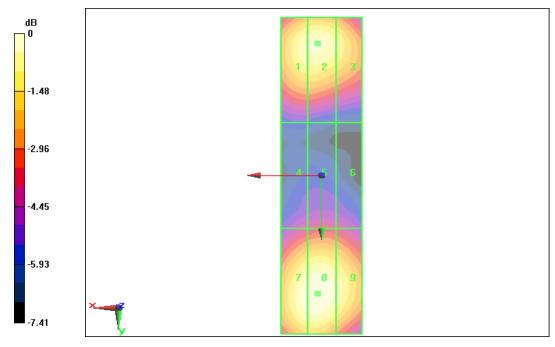
Reference Value = 134.8 V/m; Power Drift = -0.02 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.87dBV/m

MIF scaled E-field

Grid 1 <b>M2</b>	Grid 2 <b>M2</b>	Grid 3 <b>M2</b>		
39.31dBV/m	39.87dBV/m	39.36dBV/m		
Grid 4 <b>M2</b>	Grid 5 <b>M2</b>	Grid 6 M2		
36.88dBV/m	37.02dBV/m	37.05dBV/m		
Grid 7 <b>M2</b>	Grid 8 <b>M2</b>	Grid 9 <b>M2</b>		
39.26dBV/m	39.34 dB V/m	39.39dBV/m		



0 dB = 39.87 dBV/m



#### ANNEX D PROBE CALIBRATION CERTIFICATE

#### E\_Probe ER3DV6

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

TMC-SZ (Auden)

Certificate No: ER3-2424\_Jan15

#### **CALIBRATION CERTIFICATE**

Object

ER3DV6 - SN:2424

Calibration procedure(s)

QA CAL-02.v8, QA CAL-25.v6

Calibration procedure for E-field probes optimized for close near field

evaluations in air

Calibration date:

January 23, 2015

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	03-Apr-14 (No. 217-01911)	Apr-15
Power sensor E4412A	MY41498087	03-Apr-14 (No. 217-01911)	Apr-15
Reference 3 dB Attenuator	SN: S5054 (3c)	03-Apr-14 (No. 217-01915)	Apr-15
Reference 20 dB Attenuator	SN: S5277 (20x)	03-Apr-14 (No. 217-01919)	Apr-15
Reference 30 dB Attenuator	SN: S5129 (30b)	03-Apr-14 (No. 217-01920)	Apr-15
Reference Probe ER3DV6	SN: 2328	08-Oct-14 (No. ER3-2328_Oct14)	Oct-15
DAE4	SN: 789	30-Apr-14 (No. DAE4-789_Apr14)	Apr-15
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-13)	In house check: Apr-16
Network Analyzer HP 8753E	LIS37390585	18-Oct-01 (in house check Oct-14)	In house check: Oct-15

Calibrated by:

Name
Function
Signature
Leif Klysner
Laboratory Technician

Approved by:

Katja Pokovic
Technical Manager

Issued: January 26, 2015

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ER3-2424 Jan15

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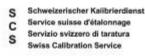


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#### Calibration Laboratory of Schmid & Partner Engineering AG Zoughausstrasse 43, 8004 Zurich, Switzerland







Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point

CF crest factor (1/duty\_cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 9 = 0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

#### Calibration is Performed According to the Following Standards:

 a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005

b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

#### Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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ER3DV6 - SN:2424 January 23, 2015

# Probe ER3DV6

SN:2424

Manufactured: Calibrated: November 12, 2007 January 23, 2015

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ER3-2424\_Jan15

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ER3DV6 - SN:2424

January 23, 2015

## DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

**Basic Calibration Parameters** 

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m) <sup>2</sup> )	1.52	1.54	1.87	± 10.1 %
DCP (mV) <sup>8</sup>	99.5	100.8	101.0	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Unc <sup>it</sup> (k=2)
0	CW	Х	0.0	0.0	1.0	0.00	155.2	±4.1 %
	1000	Y	0.0	0.0	1.0	-	194.0	
ve University date:	NAME OF THE OWNER	Z	0.0	0.0	1.0		153.3	-coresco.
10011- CAB	UMTS-FDD (WCDMA)	Х	3.09	65.7	18.0	2.91	123.9	±0.7 %
		Y	3.14	66.2	18.4		114.5	
		Z	3.14	66.0	18.1		121.7	
10021- DAB	GSM-FDD (TDMA, GMSK)	×	13.49	94.6	27.0	9.39	118.8	±1.7 %
		Y	16.96	99.7	28.6		104.8	
		Z	21.11	99.9	28.6	200	127.1	-
10028- DAB	GPRS-FDD (TDMA, GMSK, TN 0-1-2-3)	Х	33.03	99.5	23.0	3.55	128.2	±2.2 %
		Y	32.06	99.4	22.9		117.6	
		Z	55.28	99.5	22.1		130.8	
10058- DAB	EDGE-FDD (TDMA, 8PSK, TN 0-1-2-3)	Х	6.99	80.7	26.3	6.52	133.1	±1.9 %
		Y	8.89	88.7	30.3		120.9	
		Z	16.77	99.4	32.9		135.2	
10081- CAB	CDMA2000 (1xRTT, RC3)	Х	3.81	65.4	18.4	3.97	121.9	±0.7 %
20000		Y	3.74	65.2	18.3		113.5	
		Z	3.72	65.1	18.0		117.9	
10295- AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	Х	14.89	98.7	40.8	12.49	106.2	±3.3 %
		Y	13.21	95.7	39.8		94.4	
		Z	16.97	99.9	39.9		110.8	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

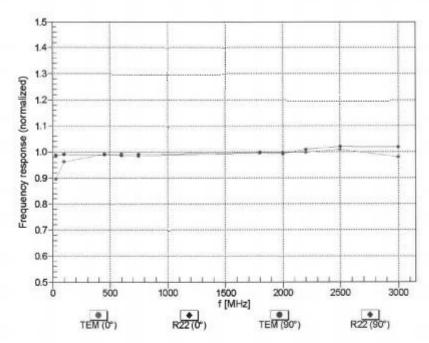
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Numerical linearization parameter: uncertainty not required.
 Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ER3DV6 - SN:2424 January 23, 2015

# Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

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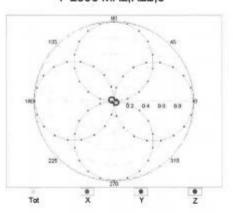


ER3DV6 - SN:2424 January 23, 2015

# Receiving Pattern ( $\phi$ ), $9 = 0^{\circ}$

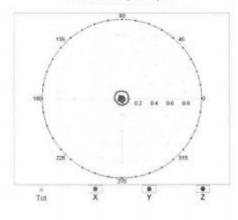
f=600 MHz,TEM,0°

f=2500 MHz,R22,0°

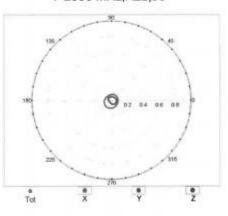


# Receiving Pattern (φ), 9 = 90°

f=600 MHz,TEM,90°



f=2500 MHz,R22,90°



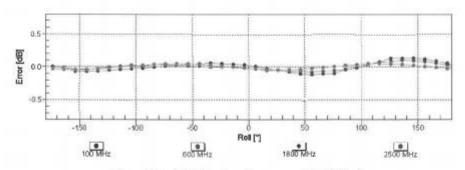
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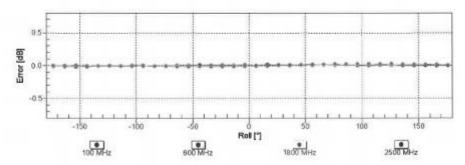
ER3DV6 – SN:2424 January 23, 2015

# Receiving Pattern (4), 9 = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

## Receiving Pattern (\$\phi\$), \$\partial = 90°

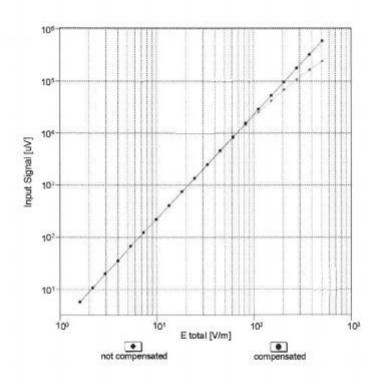


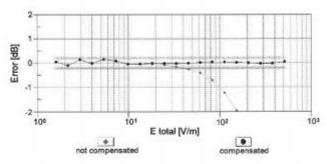
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)



ER3DV6 - SN:2424 January 23, 2015

### Dynamic Range f(E-field) (TEM cell , f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

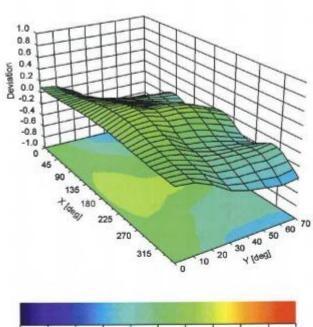
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# Deviation from Isotropy in Air Error (ø, 9), f = 900 MHz



-0.4 -0.2 0.0 0.2 0.4 0.6 0.8 1.0 -1.0 -0.8 -0.6

Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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ER3DV6 - SN:2424

January 23, 2015

## DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

#### Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-13.8
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2424\_Jan15

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### **ANNEX E DIPOLE CALIBRATION CERTIFICATE**

### Dipole 835 MHz

### Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage C Servizio svizzero di taratura S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

ALIBRATION	CERTIFICATI	E	
Dbject	CD835V3 - SN: 1	1165	
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	edure for dipoles in air	
Calibration date:	July 20, 2015		
alibration date.	ouly 20, 2010		
	ncertainties with confidence p	ional standards, which realize the physical unit robability are given on the following pages and	d are part of the certificate.
All calibrations have been con	ducted in the closed laborator	ry facility, environment temperature (22 ± 3) C	and number v 70%.
alibration Equipment used (N	M&TE critical for calibration)		
Calibration Equipment used (Normary Standards	M&TE critical for calibration)	Cal Date (Certificate No.)	Scheduled Calibration
alibration Equipment used (Normany Standards Ower meter EPM-442A	M&TE critical for calibration)  ID #  GB37480704	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020)	Scheduled Calibration Oct-15
alibration Equipment used (Northware) standards ower meter EPM-442A ower sensor HP 8481A	M&TE critical for calibration)  ID #  GB37480704  US37292783	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020)	Scheduled Calibration Oct-15 Oct-15
alibration Equipment used (Northware Standards Ower meter EPM-442A Ower sensor HP 8481A Ower sensor HP 8481A	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021)	Scheduled Calibration Oct-15 Oct-15 Oct-15
alibration Equipment used (Northward Standards Ower meter EPM-442A Ower sensor HP 8481A Ower sensor HP 8481A Ower sensor HP 8481A Ower sensor HP 8481A	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16
calibration Equipment used (Note of the Control of	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15
Calibration Equipment used (No. 2016) Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16
Calibration Equipment used (Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065	Cal Date (Certificate No.)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02021)  01-Apr-15 (No. 217-02130)  31-Dec-14 (No. ER3-2336_Dec14)  31-Dec-14 (No. H3-6065_Dec14)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15
calibration Equipment used (Normary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 Probe H3DV6 Probe EGDV6 Probe H3DV6 Probe EGDV6 Probe EGDV6 Probe H3DV6 Probe EGDV6	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15
alibration Equipment used (Normary Standards) ower meter EPM-442A ower sensor HP 8481A ower sensor HP 8481A eference 10 dB Attenuator robe ER3DV6 robe H3DV6 AE4 econdary Standards ower meter Agilent 4419B	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781	Cal Date (Certificate No.)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02021)  01-Apr-15 (No. 217-02130)  31-Dec-14 (No. ER3-2336_Dec14)  31-Dec-14 (No. DAE4-781_Sep14)  Check Date (in house)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check
Calibration Equipment used (Normary Standards Cower meter EPM-442A Cower sensor HP 8481A Cower sensor HP 8481A Reference 10 dB Attenuator Corobe ER3DV6 Crobe H3DV6 Cower meter Agilent 4419B Cower sensor HP E4412A	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781  ID #  SN: GB42420191	Cal Date (Certificate No.)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02021)  01-Apr-15 (No. 217-02021)  31-Dec-14 (No. ER3-2336_Dec14)  31-Dec-14 (No. H3-6065_Dec14)  12-Sep-14 (No. DAE4-781_Sep14)  Check Date (in house)  09-Oct-09 (in house check Sep-14)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16
alibration Equipment used (Normary Standards) ower meter EPM-442A ower sensor HP 8481A ower sensor HP 8481A leference 10 dB Attenuator robe ER3DV6 robe H3DV6 robe H3DV6 laE4 lecondary Standards lower meter Agilent 4419B lower sensor HP E4412A lower sensor HP 8482A letwork Analyzer HP 8753E	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781  ID #  SN: GB42420191  SN: US38485102  SN: US37295597  US37390585	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 109-Oct-09 (in house check Sep-14) 18-Oct-01 (in house check Oct-14)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16 In house check: Oct-15
Calibration Equipment used (Normary Standards Power meter EPM-442A Power sensor HP 8481A Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A Retwork Analyzer HP 8753E	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781  ID #  SN: GB42420191  SN: US38485102  SN: US37295597	Cal Date (Certificate No.)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02021)  01-Apr-15 (No. 217-02130)  31-Dec-14 (No. ER3-2336_Dec14)  31-Dec-14 (No. H3-6065_Dec14)  12-Sep-14 (No. DAE4-781_Sep14)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16 In house check: Sep-16
All calibrations have been con- Calibration Equipment used (Note that the content of the content	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781  ID #  SN: GB42420191  SN: US38485102  SN: US37295597  US37390585  SN: 832283/011  Name	Cal Date (Certificate No.)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02021)  01-Apr-15 (No. 217-02130)  31-Dec-14 (No. ER3-2336_Dec14)  31-Dec-14 (No. DAE4-781_Sep14)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)  18-Oct-01 (in house check Oct-14)  27-Aug-12 (in house check Oct-13)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16 In house check: Oct-15
Calibration Equipment used (Note of the Calibr	M&TE critical for calibration)  ID #  GB37480704  US37292783  MY41092317  SN: 5047.2 / 06327  SN: 2336  SN: 6065  SN: 781  ID #  SN: GB42420191  SN: US38485102  SN: US37295597  US37390585  SN: 832283/011	Cal Date (Certificate No.)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  07-Oct-14 (No. 217-02020)  01-Apr-15 (No. 217-02130)  31-Dec-14 (No. ER3-2336_Dec14)  31-Dec-14 (No. DAE4-781_Sep14)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)  18-Oct-01 (in house check Oct-14)  27-Aug-12 (in house check Oct-13)	Scheduled Calibration Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16 In house check: Sep-16 In house check: Oct-15 In house check: Oct-15

Certificate No: CD835V3-1165\_Jul15

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This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

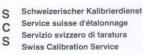


### No.I17N00032-HAC RF Page42of50

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland







Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

#### References

ANSI-C63.19-2011
 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
  (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
   In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
  distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
  figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
  is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
  directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD835V3-1165\_Jul15

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#### **Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

#### Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100mW input power	107.0V/m = 40.59 dBV/m
Maximum measured above low end	100mW input power	105.5V/m = 40.47 dBV/m
Averaged maximum above arm	100mW input power	106.3V/m ± 12.8 % (k=2)

### Appendix (Additional assessments outside the scope of SCS 0108)

#### **Antenna Parameters**

Frequency	Return Loss	Impedance
800 MHz	16.8 dB	43.1 Ω - 11.7 jΩ
835 MHz	26.9 dB	$50.6 \Omega + 4.5 j\Omega$
900 MHz	17.1 dB	56.6 Ω - 13.5 jΩ
950 MHz	21.9 dB	$45.2 \Omega + 6.2 j\Omega$
960 MHz	16.7 dB	52.1 Ω + 15.1 jΩ

#### 3.2 Antenna Design and Handling

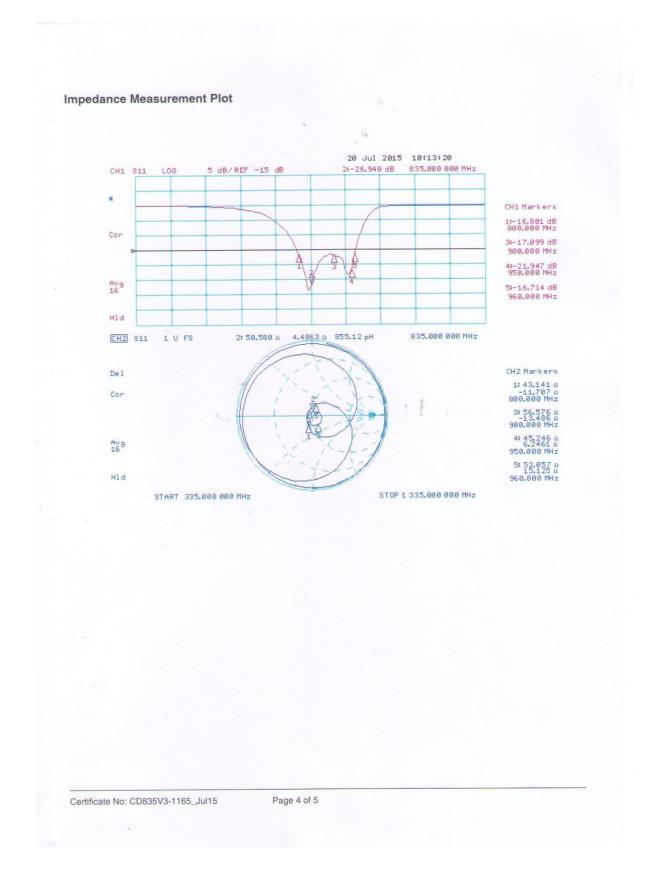
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.







#### **DASY5 E-field Result**

Date: 20.07.2015

Test Laboratory: SPEAG Lab2

### DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1165

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup> Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2014;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 12.09.2014
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

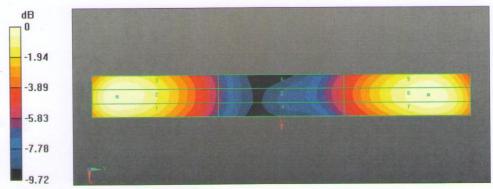
## $Dipole\ E-Field\ measurement\ @\ 835MHz/E-Scan\ -\ 835MHz\ d=15mm/Hearing\ Aid\ Compatibility\ Test\ (41x361x1):$

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 121.6 V/m; Power Drift-= -0.03 dB Applied MIF = 0.00 dB RF audio interference level = 40.59 dBV/m

Emission category: M3

#### MIF scaled E-field

0.10	Grid 2 M3 40.59 dBV/m	Grid 3 M3
		Grid 6 M4
35.78 dBV/m	35.96 dBV/m	35.9 dBV/m
	Grid 8 M3 40.47 dBV/m	Grid 9 M3 40.35 dBV/m



0 dB = 107.0 V/m = 40.59 dBV/m

Certificate No: CD835V3-1165\_Jul15

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### Dipole 1880 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

TMC-SZ (Auden)

Object	CD1880V3 - SN:	1149	
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	dure for dipoles in air	
Calibration date:	July 20, 2015		
	4		
		robability are given on the following pages and $y$ facility: environment temperature $(22 \pm 3)^{\circ}$ C	
Calibration Equipment used (M8	TE critical for calibration)		
	1	Cal Data (Cartificata No.)	Schodulad Calibration
Primary Standards	ID # GB37480704	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020)	Scheduled Calibration Oct-15
Primary Standards Power meter EPM-442A	ID#	Cal Date (Certificate No.) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020)	
Primary Standards Power meter EPM-442A Power sensor HP 8481A	ID # GB37480704	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020)	Oct-15
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A	ID # GB37480704 US37292783	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021)	Oct-15 Oct-15
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator	ID # GB37480704 US37292783 MY41092317	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130)	Oct-15 Oct-15
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14)	Oct-15 Oct-15 Oct-15 Mar-16
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4 Recondary Standards Power meter Agilent 4419B	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID #	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A	ID #  GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 09-Oct-09 (in house check Sep-14)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A Network Analyzer HP 8753E	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102 SN: US37295597	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14)	Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16
Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A Network Analyzer HP 8753E	ID # GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102 SN: US37295597 US37390585	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 18-Oct-01 (in house check Oct-14)	Oct-15 Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16 In house check: Oct-15
Calibration Equipment used (M&Primary Standards Power meter EPM-442A Power sensor HP 8481A Power sensor HP 8481A Reference 10 dB Attenuator Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP B482A Network Analyzer HP 8753E RF generator R&S SMT-06  Calibrated by:	ID #  GB37480704 US37292783 MY41092317 SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191 SN: US38485102 SN: US37295597 US37390585 SN: 832283/011	07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02020) 07-Oct-14 (No. 217-02021) 01-Apr-15 (No. 217-02130) 31-Dec-14 (No. ER3-2336_Dec14) 31-Dec-14 (No. H3-6065_Dec14) 12-Sep-14 (No. DAE4-781_Sep14) Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 18-Oct-01 (in house check Oct-14) 27-Aug-12 (in house check Oct-13)	Oct-15 Oct-15 Oct-15 Oct-15 Mar-16 Dec-15 Dec-15 Sep-15 Scheduled Check In house check: Sep-16 In house check: Sep-16 In house check: Oct-15 In house check: Oct-15

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

#### References

 ANSI-C63.19-2011
 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
  (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
  In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
  distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
  figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
  is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
  directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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#### **Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

#### Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100mW input power	90.6V/m = 39.14 dBV/m
Maximum measured above low end	100mW input power	89.3V/m = 39.01 dBV/m
Averaged maximum above arm	100mW input power	90.0V/m ± 12.8 % (k=2)

### Appendix (Additional assessments outside the scope of SCS 0108)

#### **Antenna Parameters**

Frequency	Return Loss	Impedance
1730 MHz	24.1 dB	50.5 Ω + 6.2 jΩ
1880 MHz	22.2 dB	48.9 Ω + 7.6 jΩ
1900 MHz	22.5 dB	51.6 Ω + 7.4 jΩ
1950 MHz	31.1 dB	52.6 Ω + 1.1 jΩ
2000 MHz	20.0 dB	$40.9 \Omega + 0.2 j\Omega$

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

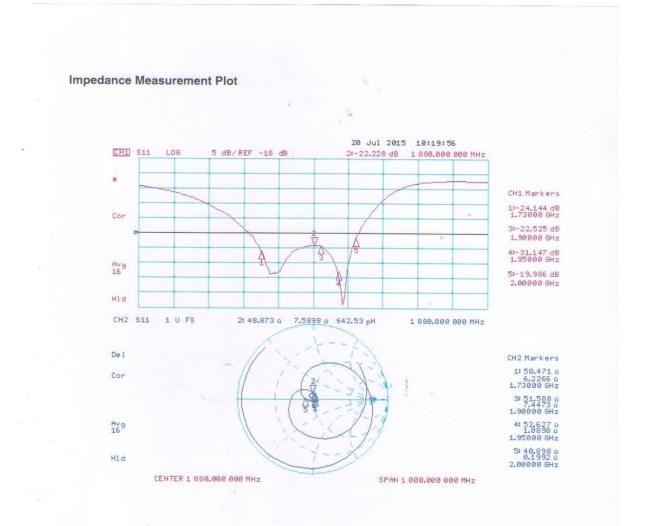
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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#### **DASY5 E-field Result**

Date: 20.07.2015

Test Laboratory: SPEAG Lab2

#### DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1149

Communication System: UID 0 - CW ; Frequency: 1880 MHz Medium parameters used:  $\sigma=0$  S/m,  $\epsilon_r=1$ ;  $\rho=1000$  kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

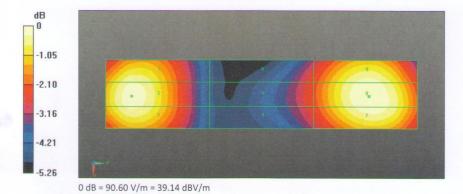
- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2014;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 12.09.2014
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

#### Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1);

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 139.7 V/m; Power Drift = -0.00 dB
Applied MIF = 0.00 dB
RF audio interference level = 39.14 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
38.89 dBV/m	39.01 dBV/m	38.79 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
36.77 dBV/m	36.91 dBV/m	36.79 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
39.03 dBV/m	39.14 dBV/m	38.96 dBV/m



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